

产品规格书

SPECIFICATIONS FOR PRODUCT

产品类型	TYPE	:	Crystal
产品规格	SPEC	:	12MHz/5032/20PF/20PPM
产品型号	P/N	:	CJ11-120002020A20
日期	DATE	:	2020/08/02

核准及签名			部バ
R&D APPR.	SIGNATURED		DEPT.
拟制	审核	批准	频率器件事业部
ISSUE	CHECK	APPROVAL	
魏永鑫	徐亚洲	杨立新	
2020/08/02	2020/08/02	2020/08/02	

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SMD5032 2pads Crystal Resonator

CJ11-120002020A20

- 1. Scope:
- 1.1 This specification applies to the RoHS/SONY compliance quartz crystal unit with a frequency of 12MHz which will be used in crystal oscillator applications.
- 2. Construction:

JSCJ

2.1 Type of Quartz Resonator: SMD5032 2pads

3. Electrical Characteristics

3.1	Nominal Frequency(f):	12.000MHz
3.2	Load Capacitance(C _L):	20pF
3.3	Frequency Tolerance(\triangle f/f):	±20ppm
3.4	Frequency Temperature Stability:	±20ppm
3.5	Resonance Resistance(ohm):	60ohms Max
3.6	Osc mode:	Fundamental mode
3.7	Shunt Capacitance(C ₀):	<2pF
3.8	Drive Level(D _L):	<300µW
3.9	Operating Temperature Range(T _{OPR}):	-20 to + 70°C
3.10) Storage Temperature Range(T _{STG}):	-55 to + 125°C
3.11	Insulation Resistance(IR):	>500 M ohms
3.12	2 Aging(△f _A):	± 3ppm per Year

4. Reliability Specifications

This is the quality control and quality assurance and reliability tests performance dataforthe RoHS SONY compliance

12MHz SMD5032 2pads crystal resonators

related to the specification and approval sheet provided by JSCJ.

Standard test condition (TEMP.: 20±5°C. Relative humidity: 65±20%)

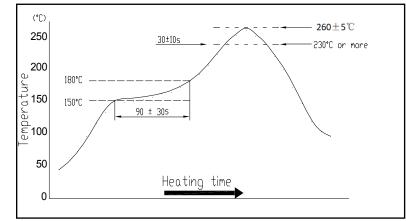
For any discrepancy in GO/NG, test will be done at TEMP.25±2°C, R.H. 65±5%.

NO.	PROCESS	SPECIFICATION	TEST METHOD
4.1	Temperature Cycle (GB/T 2423.22-2002, Method Nb)	Frequency change after test ≤± 5ppm.Resonance resistance change after test ≤10ohms.	10 cycles from -55°C to 125°C. Measurement taken after DUT being left at room temperature for 24±2 hours.
4.2	Ăa)	Frequency change after test ≤± 5ppm.Resonance resistance change after test ≤10ohms.	Spending 72 hrs at -55°C±3°C constant temperature. Measurement taken after DUT being left at room temperature for 24±2 hours.
4.3	High Temperature Storage (GB/T 2423.2-2001, Method Ba)	Frequency change after test ≤± 5ppm.Resonance resistance change after test ≤10ohms.	Spending 72 hrs at 125°C±3°C constant temperature. Measurement taken after DUT being left at room temperature for 24±2 hours.
4.4	Humidity (GB/T 2423.3- 2006, Method Cab)	Frequency change after test ≤± 5ppm.Resonance resistance change after test ≤10ohms.	Spending 96 hrs at 40 °C \pm 3 °C, with 93 %R.H, Then keep the DUT in dry oven at 40 \pm 5 °C for 24 hour. Measurement taken after DUT being left at room temperature for 1 to 2 hours.
4.5	Vibration (GB/T 2423.10- 1995, Method Fc)	Frequency change after test ≤± 5ppm.Resonance resistance change after test ≤10ohms.	Apply 0.75mm vibration at sweep frequency 10~ 500 Hz, 10 cycles in each direction of 3 axis. Measurement taken after 1 hour.
4.6	Shock (GB/T 2423.5-1995, Method Ea)	Frequency change after test ≤± 5ppm.Resonance resistance change after test ≤10ohms.and exhibit no visible damage.	Peak 1000m/s2, normal width 6ms half sine wave form, 3.7m/s, 3 perpendicular axis of samples, 3 cycles / direction, total 18 cycles. Measurement taken after 1 hour.
4.7	Drop (GB/T 2423.8-1995, Method Ed)	Frequency change after test ≤± 5ppm.Resonance resistance change after test ≤10ohms.and exhibit no visible damage.	Free drop to the steel plate with thickness of 3 mm from 1.00 m heights for 3 times.
4.8	Solderability (IEC60068-2- 58,Test Td:)	Terminals shall be covered more then 95% with solder.	Passed through the re-flow oven under the following condition. Preheat 150 to 180° C for 60 to 120sec, and soldering time for $20s \pm 5s$ at 235° C, peak soldering time for $10s \pm 1s$ betweein 240 and 250°C. There is no need to do functional test. 8-12X magnifier.
4.9	Terminal Strength (JIS-C- 6429 Method 1 & 2)	No visible damage	Mount on a glass-epoxy board (100x50x1.6mm), then bend to 2mm displacement (velocity 1mm/sec) and keep for 5 seconds. or pulling force 1.8kg for at least 60 seconds.
4.10	Resistance to Soldering Heat (IEC60068-2-58,Test Td: Table 4)	Frequency change after test ≤± 5ppm.Resonance resistance change after test ≤10ohms.	Passed through the re-flow oven under the following condition. Preheat 150 to 180°C for 60 to 120sec, and sodering time for 60s max at 235°C, peak soldering time for 20s max at 265°C max. Measurement taken after DUT being left at room temperature for at least 2 hours.
4.11	OTHERS		

5. Recommended Reflow soldering condition (SMD)

Solder profile

Peak: 260±5°C Soldering zone: 230°C or more, 30±10s. Pre-heating zone 1: 150 \sim 180°C, 90±30s

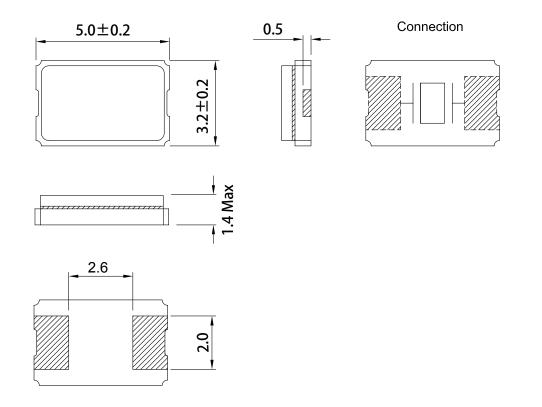


Temperature profile for reflow soldering

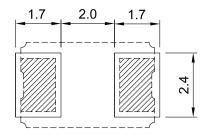
6. Soldering iron method

Bit temperature: 350 ± 10 °C Application time of soldering iron:3+1 s. For other procedures, refer to IEC 60068-2-20.

Package Outline Dimensions

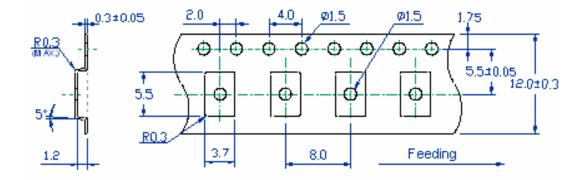


Suggested Pad Layout

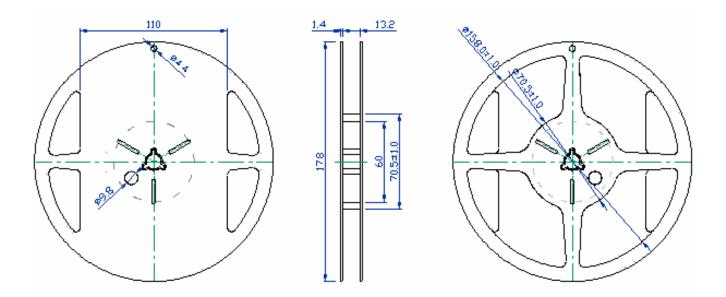


NOTICE

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Reel Dimensions(unit: mm)



1.230mm minimum leafer which consist of carrier and/or tape followed by a minimum of 160mm of empty carrier tape sealed with cover tape.

2.160mm minimum trailer of empty carrier tape sealed with cover tape.

*1000pcs/Reel